Power MOSFET

40 V, 70 A, Single N-Channel, DPAK

Features

- Low R_{DS(on)}
- High Current Capability
- Low Gate Charge
- These are Pb-Free Devices

Applications

- Electronic Brake Systems
- Electronic Power Steering
- Bridge Circuits

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Units
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage			V_{GS}	±20	V
Continuous Drain	Steady	$T_C = 25^{\circ}C$	I _D	70	Α
Current – R _{θJC} (Note 1)	State	T _C = 100°C		50	
Power Dissipation – R _{θJC} (Note 1)	Steady State T _C = 25°C		P _D	100	W
Pulsed Drain Current	t _p =	= 10 μs	I_{DM}	150	Α
Operating Junction and Storage Temperature			T _J , T _{STG}	–55 to 175	°C
Source Current (Body Diode) Pulsed			I _S	63.5	Α
Single Pulse Drain-to Source Avalanche Energy – (V_{DD} = 50 V, V_{GS} = 10 V, I_{PK} = 30 A, L = 1 mH, R_G = 25 Ω)			EAS	450	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

THERMAL RESISTANCE RATINGS (Note 1)

Parameter	Symbol	Max	Units
Junction-to-Case (Drain)	$R_{\theta JC}$	1.5	°C/W

^{1.} Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).

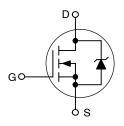


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} TYP	I _D MAX (Note 1)
40 V	8.7 mΩ @ 10 V	70 A

N-Channel





CASE 369C STYLE 2

MARKING DIAGRAM



= Year WW = Work Week

= Specific Device Code 5406N G = Pb-Free Device

ORDERING INFORMATION

Device	Package	Shipping†
NTD5406NG	DPAK (Pb-Free)	75 Units / Rail
NTD5406NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

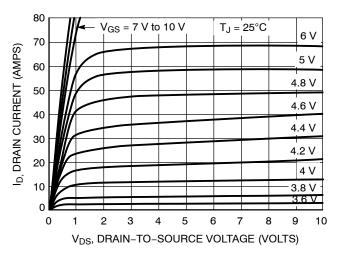
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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise stated)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				42		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25°C			1.0	μΑ
		V _{DS} = 40 V	T _J = 100°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = ±30 V				±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _I	ο = 250 μΑ	1.5		3.5	V
Gate Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-7.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 30 A		8.7	10	mΩ
		V _{GS} = 5.0 V,	I _D = 10 A		13.2	17	
Forward Transconductance	9FS	V _{GS} = 10 V,	I _D = 10 A		19		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1375	2500	pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = V_{DS} = 0$: 1.0 MHz, 32 V		370	700	
Reverse Transfer Capacitance	C _{RSS}	V DS = 32 V			160	300	
Total Gate Charge	Q _{G(TOT)}				45		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 32 V, I _D = 30 A			2.0		
Gate-to-Source Charge	Q_{GS}				5.4		
Gate-to-Drain Charge	Q_{GD}				20		
SWITCHING CHARACTERISTICS, V	GS = 10 V (Note	: 3)					
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DD} = 32 V, I_{D} = 30 A, R_{G} = 2.5 Ω			7.2		ns
Rise Time	t _r				57		
Turn-Off Delay Time	t _{d(OFF)}				30		7
Fall Time	t _f				67		
SWITCHING CHARACTERISTICS, V	GS = 5 V (Note 3	3)					
Turn-On Delay Time	t _{d(ON)}				15		ns
Rise Time	t _r	V _{GS} = 5.0 V, \	/ _{DD} = 20 V,		147		
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 30 \text{ A}, R_G = 2.5 \Omega$			20		
Fall Time	t _f				29		
DRAIN-SOURCE DIODE CHARACTE	ERISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 10 A	$T_{J} = 25^{\circ}C$ $T_{J} = 125^{\circ}C$		0.82 0.67	1.1	V
Reverse Recovery Time	t _{RR}		13 - 120 0		46		ns
Charge Time		$V_{GS} = 0 \text{ V, } dI_{SD}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$			24		
Discharge Time	t _a				22		
Reverse Recovery Charge	+				65		nC
 2. Pulse Test: pulse width ≤ 300 us. du	Q _{RR}				00		110

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

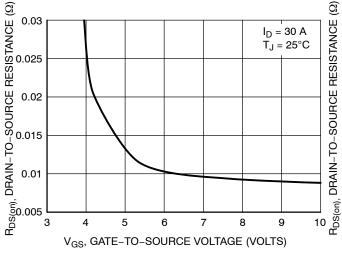
TYPICAL PERFORMANCE CURVES



80 $V_{DS} \ge 10 \text{ V}$ 70 ID, DRAIN CURRENT (AMPS) 60 50 40 30 T_J = 100°C 20 $T_J = 25^{\circ}C$ 10 $T_{.1} = -55^{\circ}C$ 0 0 8 5 6 V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



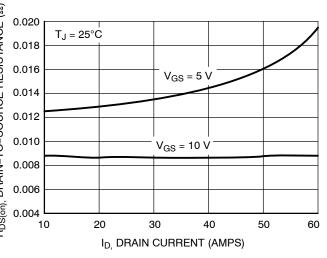
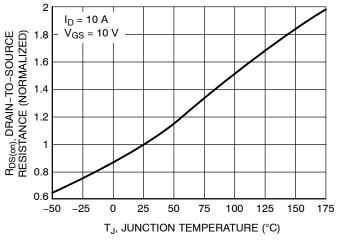


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



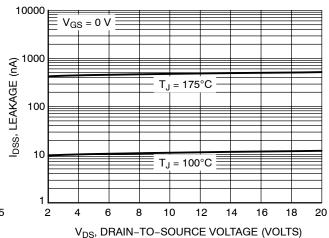
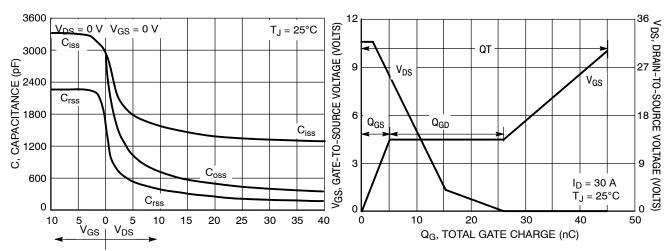


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

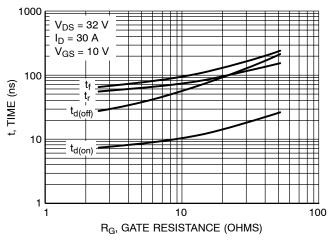


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

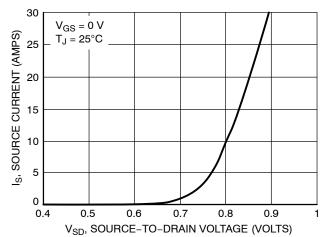
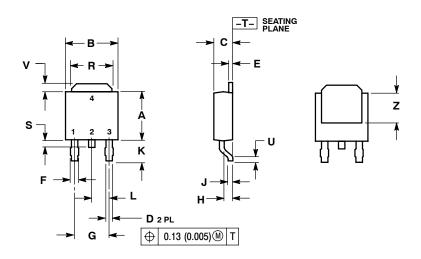


Figure 10. Diode Forward Voltage vs. Current

PACKAGE DIMENSIONS

DPAK CASE 369C-01 **ISSUE O**



- NOTES:
 1. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

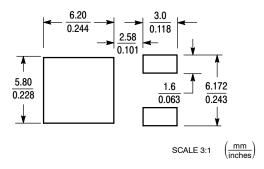
	INCHES		MILLIM	ETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180	BSC	4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090 BSC		2.29 BSC		
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
٧	0.035	0.050	0.89	1.27	
7	0 155		3 93		

STYLE 2:

PIN 1. GATE 2. DRAIN 3. SOURCE

4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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